

Report No. MCR-23-0499 Date: Nov./10/2023

RENESAS SEMICONDUCTOR RELIABILITY REPORT

- SERIES : RL78/F13
- DEVICE : R5F10A6xYSP/R5F10A6xYXXXSP (x=A/C/D/E)
- APPLICATION : Automobile

Quality Assurance Div. Renesas Electronics Corporation

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Notice

Q100 Qualification Test Results for R5F10A6xYSP/R5F10A6xYXXXSP(x=A/C/D/E)

[Note : Basically qualification tests were performed using a representative product with the same wafer process and the same package structure .]

Test	#	Reference	Test Conditions		S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)				
	TEST GROUP A – ACCELERATED ENVIRONMENT STRESS TESTS											
PC	A1	JESD22 A113 J-STD-020	Preconditioning: (Test @ Rm) SMD only; Moisture Preconditioning for THB/HAST, AC/UHST, TC, &PTC ; Peak Reflow Temp=260°C	Min.MSL=3		MSL=3	-					
THB or HAST	A2	JESD22 A101	Temperature Humidity Bias: (Test @ Rm/Hot) Ta=85°C, RH=85%, 1000hrs	3	77	231	0 of 231	-				
AC or UHST o r TH	A3	JESD22 A102	Autoclave : (Test @ Rm) Ta=121°C, P=2atm, RH=100%, 96hrs	3	3 77 231		0 of 231	-				
тс	A4	JESD22 A104	Temperature Cycle: (Test @ Hot) Ta=-65°C to 175°C, 500cyc	3	3 77 231		0 of 231	-				
PTC	A5	JESD22 A105	Power Temperature Cycle: (Test @ Rm/Hot)	-			-	N/A				
HTSL	A6	JESD22 A103	High Temperature Storage Life: (Test @ Rm/Hot) Ta=150°C, 2000hrs	1 45 45		0 of 45	-					

TEST GROUP B – ACCELERATED LIFETIME SIMULATION TESTS

HTOL	B1	JESD22 A108	High Temp Operating Life: (Test @ Rm/Cold/Hot) Ta=150°C, 1000hrs		3	77	231	0 of 231	-
ELFR	B2	AEC-Q100-008	Early Life Failure Rate: (Test @ Rm/Hot) Ta=150°C, 48hrs		3	800	2400	0 of 2400	-
EDR	В3	$\Delta EC_{-}(0100_{-}005)$	NVM Endurance & Data Retention Test: (Test @ Rm/Hot)	For HTOL	3	77	231	0 of 231	-
EDK	5			For HTSL	1	45	45	0 of 45	-

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Test	#	Reference	Test Conditions		S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)			
	TEST GROUP C – PACKAGE ASSEMBLY INTEGRITY TESTS										
WBS	S C1 AEC-Q100-001 Wire Bond Shear Test: (Ppk > 1.67 and Cpk > 1.33)		30 bonds	5 parts Min.	30 bonds	0 of 30bonds	Ppk>1.67				
WBP	C2	Mil-STD-883 Method 2011	Wire Bond Pull: (Ppk > 1.67 and Cpk > 1.33); Each bonder used	30 bonds	5 parts Min.	30 bonds	0 of 30bonds	Ppk>1.67			
SD	C3	JESD22 B102	Solderability: (>95% coverage) Solder temp: 245C, Solder Immersion time: 5sec	1	15	15	0 of 15	-			
PD	C4	JESD22 B100, JESD22 B108	Physical Dimensions: (Ppk > 1.67 and Cpk > 1.33)	3	10	30	0 of 30	Ppk>1.67			
SBS	C5	AEC-Q100-010	Solder Ball Shear: (Ppk > 1.67 and Cpk > 1.33)	-	-	-	-	N/A			
LI	C6	JESD22 B105	Lead Integrity: (No lead cracking or breaking); Through-hole only	-	-	-	-	N/A			

TEST GROUP D – DIE FABRICATION RELIABILITY TESTS

EM	D1	JESD61	Electromigration:	-	-	-	Pass	Confirmed by process TEG
TDDB	D2	JESD35	Time Dependant Dielectric Breakdown:	-	-	-	Pass	Confirmed by process TEG
HCI	D3	JESD60 & 28	Hot Carrier Injection:	-	-	-	Pass	Confirmed by process TEG
NBTI	D4	JESD90	Negative Bias Temperature Instability:	-	-	-	Pass	Confirmed by process TEG
SM	D5	JESD61,87 & 202	Stress Migration:	-	-	-	Pass	Confirmed by process TEG

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Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)
			TEST GROUP E- ELE	CTRICAL	VERIFICA	TION		
TEST	E1	User/Supplier Specification	Pre and Post Stress Electrical Test:	All	All	All	0 of All	-
HBM/ MM	E2	AEC-Q100-002 AEC-Q100-003	Electrostatic Discharge, Human Body Model / Machine Model: (Test @ Rm/Hot); (2KV HBM / 200V MM) At least one of these models must be performed.	1	HBM:3 MM:3	6	0 of 6 ESD Level= HBM: H2 MM: M3	HBM: 2000V Pass MM: 200V Pass
CDM	E3	AEC-Q100-011	Electrostatic Discharge, Charged Device Model: (Test @ Rm/Hot); (750V corner leads, 500V all other leads)	1	3	3	0 of 3 ESD Level= CDM: C4B	Corner leads: 750V Pass All other leads:500V Pass *Only Direct charge method
LU	E4	AEC-Q100-004	Latch-Up: (Test @ Rm/Hot)	1	6	6	0 of 6	-
ED	E5	AEC-Q100-009 AEC-Q003	Electrical Distributions: (Test @ Rm/Hot/Cold) (Cpk > 1.33, Ppk > 1.67)	3	30	90	0 of 90	Ppk>1.67
FG	E6	AEC-Q100-007	Fault Grading:	-	-	-	>98%	-
CHAR	E7	AEC-Q003	Characterization: (Test @ Rm/Hot/Cold)	-	-	-	Pass	According to Renesas standard procedure
GL	E8	AEC-Q100-006	Electro-Thermally Induced Gate Leakage: (Test @ Rm)	1	6	6	0 of 6	-
EMC	E9	SAE J1752/3	Electromagnetic Compatibility (Radiated Emissions)	1	1	1	0 of 1	-
SC	E10	AEC Q100-012	Short Circuit Characterization	-	-	-	-	N/A
SER	E11	JESD89-1 JESD89-2 JESD89-3	Soft Error Rate	1	3	3	Pass	-

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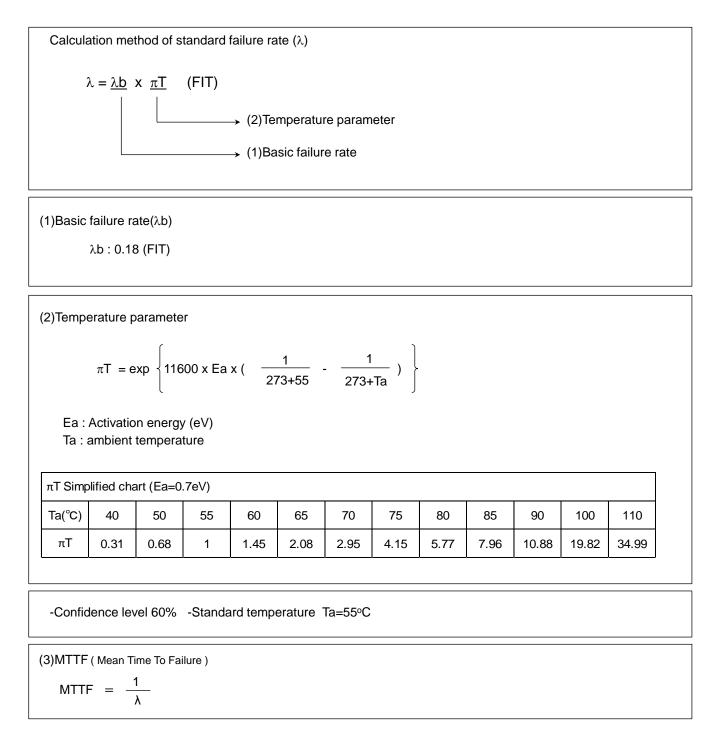
Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)		
<u></u>			TEST GROUP F – DE	FECT SCR	EENING T	ESTS				
PAT	T F1 AEC-Q001 Process Average Testing: (see AEC-Q001)		All	All	All	Reject units outside PAT limits	Apply to mass production according to Renesas standard procedure			
SBA	F2	AEC-Q002	Statistical Bin/Yield Analysis: (see AEC-Q002)	All	All	All	Reject units outside criteria	Apply to mass production according to Renesas standard procedure		
	TEST GROUP G - CAVITY PACKAGE INTEGRITY TESTS (for Ceramic Package testing only)									
MS	G1	JESD22 B104	Mechanical Shock: (Test @ Rm)	-	-	-	-	N/A		
VFV	G2	JESD22 B103	Variable Frequency Vibration: (Test @ Rm)	-	-	-	-	N/A		
CA	G3	MIL-STD-883 Method 2001	Constant Acceleration: (Test @ Rm)	-	-	-	-	N/A		
GFL	G4	MIL-STD-883 Method 1014	Gross and Fine Leak:	-	-	-	-	N/A		
DROP	G5		Drop Test: (Test @ Rm) MEMS cavity parts only. Drop part on each of 6 axes once from a height of 1.2m onto a concrete surface.	-	-	-	-	N/A		
LT	G6	MIL-STD-883 Method 2004	Lid Torque:	-	-	-	-	N/A		
DS	G7	MIL-STD-883 Method 2019	Die Shear:	-	-	-	-	N/A		
IWV	G8	MIL-STD-883 Method 1018	Internal Water Vapor:	-	-	-	-	N/A		



Calculation method of standard failure rate

Target : 0.13um CMOS process product (RL78 series Automobile)

Operating reliability is decided by inherent reliability of device and environment condition of use (See below).



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	uct list	Due duich is eit is use here	De alva sa da	Na	Creation	-	t No. MCR-23-0499
No	Group	Product part number	Package code	No	Group	Product part number	Package code
1	RL78/F13	R5F10A6AYSP	PLSP0020JC-B	51	_		
2	RL78/F13	R5F10A6AYXXXSP	PLSP0020JC-B	52	_		
3	RL78/F13	R5F10A6CYSP	PLSP0020JC-B	53	_		
4	RL78/F13	R5F10A6CYXXXSP	PLSP0020JC-B	54	_		
5	RL78/F13	R5F10A6DYSP	PLSP0020JC-B	55	_		
6	RL78/F13	R5F10A6DYXXXSP	PLSP0020JC-B	56	_		
7	RL78/F13	R5F10A6EYSP	PLSP0020JC-B	57	_		
8	RL78/F13	R5F10A6EYXXXSP	PLSP0020JC-B	58	-		_
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